

# ABSTRACT OF THE DISCLOSURE

A CMP slurry for ruthenium titanium nitride and a polishing process using the same. In a process technology below  $0.1\mu\text{m}$ , when a capacitor using a  $(\text{Ba}_{1-x}\text{Sr}_x)\text{TiO}_3$  film as a dielectric film is fabricated, the slurry is used to polish a ruthenium titanium nitride film deposited as a barrier film according to a CMP process. The CMP process is performed by using the slurry, to improve a polishing speed of ruthenium titanium nitride under a low polishing pressure. In addition, the CMP process is performed according to an one-step process by using one kind of slurry. As a result, defects on an insulating film are reduced and a polishing property is improved, thereby simplifying the CMP process.